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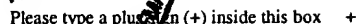
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M. LUCENTE, et al., "Nonlinear mixing and phase conjugation in broad-area diode lasers,"
320 Applied Physics Letter, 53 (1988) 8 August, No. 6, New York, NY, USA, pp. 467-469

J.P. HALL, et al., "Packaging of VCEL, MC-LED and Detector 2-D Arrays," 1998 Electronic Components and Technology Conference, pp. 778-782

P. KURZ, et al., "Phase conjugate reflectivity of 165% using four-wave mixing in a broad-area laser diode," Lasers and Electro-Optics Society Annual Meeting Conference Proceedings, IEEE, October 30, 1995, pp. 410-411

R. LANG, "Theory of Grating-Confined Broad-Area Lasers," IEEE Journal of Quantum Electronics, Vol. 34, No. 11, November 1998, pp. 2196-2209

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